

Deep Learning and Optimization

Unpacking Transformers, LLMs and Diffusion

Session 2

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slack #ensae-dl-2025

Summary of Session 1

Neural networks are compute graphs.

Gradient descent minimizes a loss function over the network's parameters.

Back-propagation allows efficient learning (tuning of the network).

We built a Multi-Layer Perception (MLP) from scratch.

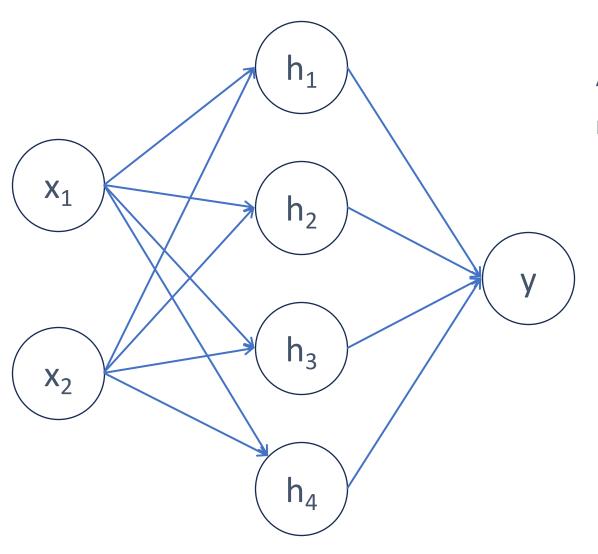
Session	Date	Topic
1	05-02-2025	Intro to Deep Learning Practical: micrograd
2	12-02-2025	DL fundamentals • Backprop • Loss functions Practical: bigram, MLP for next character prediction
3	19-02-2025	DL Fundamentals II
	26-02-2025	Pas de cours
4	05-03-2025	Attention & Transformers Practical: GPT from scratch
5	12-03-2025	DL for computer vision Practical: Convnets for CIFAR-10
6	19-03-2025	VAE & Diffusion models Practical: diffusion from scratch Quiz/Exam

There is no reason for deep learning to work

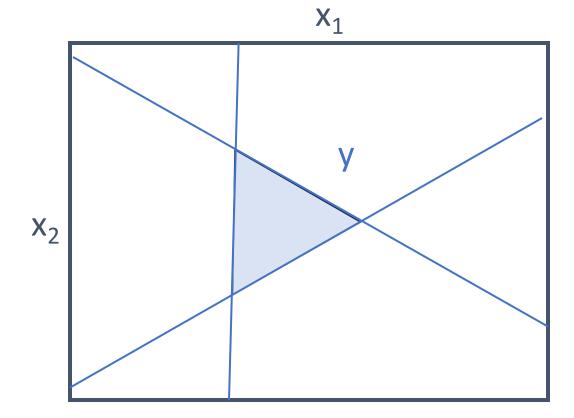
Training: Finding the global optimum of an arbitrary non-convex function is NP-hard (Murty & Kabadi, 1987).

Generalization: deep networks generate way more regions than training samples.

Neural networks generate large number of regions



A neural network generate linear subregions in the output space.



Neural networks generate large number of regions

Shallow model

Deep model

 $O(n^d)$ regions

 $O(n^{dL})$ regions

n units, d dim.

L layers

Deep networks generate even more of regions / parameter count

The number of regions grows exponentially with the depth of the network but only polynomially with the width of the hidden layers [1].

→ Deep neural networks create much more complex functions for a fixed parameter budget.

[1] On the number of linear regions of deep neural networks, Montufar et al, NeurIPS 2014.

Deep networks generate even more of regions / parameter count

1D input, 5 layers, 10 units / layer → 471 parameters, 161,051 regions

10D input, 5 layers, 50 units / layer \rightarrow 10,801 parameters, $> 10^{40}$ regions

Number of atoms in the universe: 10⁸⁰

Let's venture into the variations of deep networks

Network architecture and inductive bias

Loss function

Activation function

Regularization

Initialization

Residual networks

Batch norm, layer norm

Inductive bias

Set of assumptions made by the model about the relationship between input data and output data.

Examples:

- Minimum features
- Maximum margin (SVM)
- Minimum cross-validation error
- Neural net architecture (convnet, transformer)

Inductive bias

No free-lunch theorem

Every learning algorithm is as good as any other when averaged over all sets of problems.

→ You can't just learn « purely from data » without bias.

Empirical evidence: shallow networks don't work as well as deeper ones.

Intuition:

- Deep networks can represent more complex functions with the same parameter count
- 2. Deep networks are easier to train
- 3. Deep network impose better inductive bias

The challenges of depth

- Vanishing/exploding gradients
- Shattered gradients

In short, depth is required but comes with challenges that need to be addressed.

Let's venture into the variations of a deep networks

Network architecture and inductive bias

Loss function

Activation function

Regularization

Initialization

Residual networks

Batch norm, layer norm

Let's venture into the variations of a deep networks

Loss functions are a fundamental component of a deep learning.

We will learn about cross-entropy on a simple model (bigram)...

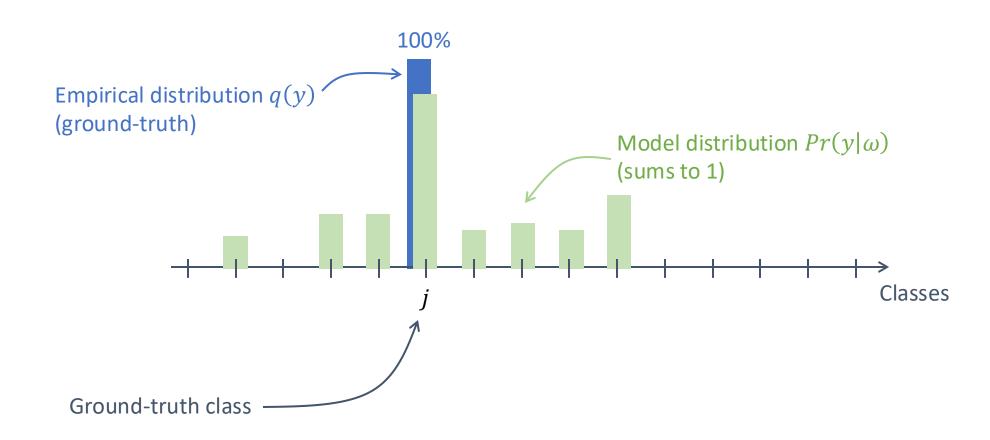
... and reuse it throughout this course!

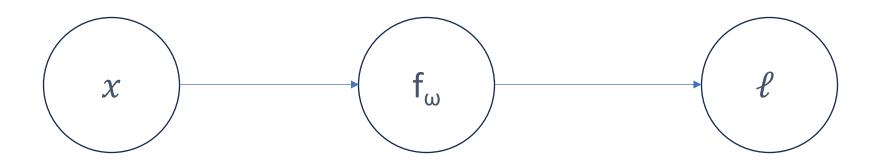
Let's venture into the variations of a deep networks

Fundamentally, the loss function expresses the distance between two distributions:

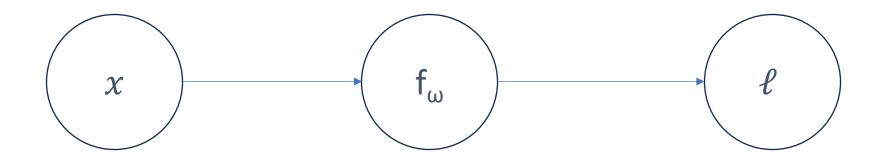
- The distribution of real data
- The distribution of predicted data

Loss functions: example for classification



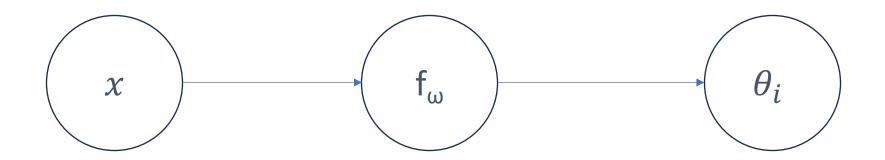


$$\ell = (y - \hat{y})^2$$
ground-truth



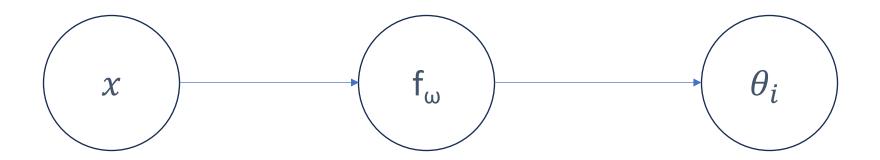
$$\ell = (y - \hat{y})^2$$

Expressed as the distance between two distributions



$$f_{\omega}(x_i) = \theta_i$$

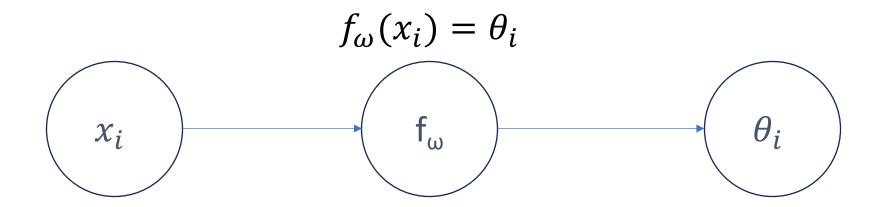
Parameters of a distribution



$$f_{\omega}(x_i) = \theta_i$$

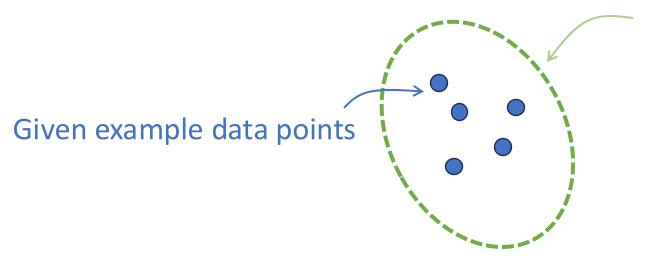
The distribution is chosen based on the domain.

The model computes the optimal θ_i given the data.



Example: univariate regression

$$\Pr(y|\mu,\sigma^2) = \frac{1}{\sqrt{2\pi\sigma^2}} e^{\frac{(y-\mu)^2}{2\sigma^2}}$$



Find the optimal parameters of the distribution $f_{\omega}(x_i) = \theta_i$

The parameters ω are the same across all samples x_i

$$\widehat{\omega} = \underset{\omega}{\operatorname{argmax}} \left[\prod_{i=1}^{N} \Pr(y_i | x_i) \right]$$

$$= \underset{\omega}{\operatorname{argmax}} \left[\prod_{i=1}^{N} \Pr(y_i | \theta_i) \right]$$

$$= \underset{\omega}{\operatorname{argmax}} \left[\prod_{i=1}^{N} \Pr(y_i | f_{\omega}(x_i)) \right]$$

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$$= \underset{\omega}{\operatorname{argmax}} \left[\prod_{i=1}^{N} \Pr(y_i | f_{\omega}(x_i)) \right]$$

 $Pr(y_1, y_2, ..., y_N | x_1, x_2, ..., x_N)$

Data is assumed i.i.d

$$\widehat{\omega} = \underset{\omega}{\operatorname{argmax}} \left[\prod_{i=1}^{N} \Pr(y_i | x_i) \right]$$

$$= \underset{\omega}{\operatorname{argmax}} \left[\prod_{i=1}^{N} \Pr(y_i | \theta_i) \right]$$

$$= \underset{\omega}{\operatorname{argmax}} \left[\prod_{i=1}^{N} \Pr(y_i | f_{\omega}(x_i)) \right]$$

$$= \underset{\omega}{\operatorname{argmax}} \left[\sum_{i=1}^{N} \log[\Pr(y_i | f_{\omega}(x_i))] \right]$$

$$= \underset{\omega}{\operatorname{argmin}} \left[-\sum_{i=1}^{N} \log[\Pr(y_i|f_{\omega}(x_i))] \right]$$
 Negative log likelihood (NLL)

Inference

$$f_{\omega}(x_i) = \theta_i$$

Optimal choice: maximum of the distribution

...or sample from the distribution!

In the case of the univariate regression, the NLL is equivalent to least squares.

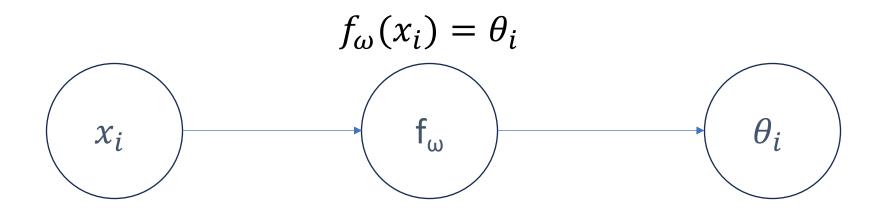
$$\widehat{\omega} = \underset{\omega}{\operatorname{argmin}} \left[-\sum_{i=1}^{N} \log[\Pr(y_i|f_{\omega}(x_i))] \right] \quad \text{Negative log likelihood (NLL)}$$

$$\widehat{\omega} = \underset{\omega}{\operatorname{argmin}} \left[-\sum_{i=1}^{N} \log \left[\frac{1}{\sqrt{2\pi\sigma^2}} e^{-\frac{(y_i - \mu)^2}{2\sigma^2}} \right] \right]$$

$$\widehat{\omega} = \underset{\omega}{\operatorname{argmin}} \left[-\sum_{i=1}^{N} \log \left[\frac{1}{\sqrt{2\pi\sigma^2}} e^{-\frac{(y_i - f_{\omega}(x_i))^2}{2\sigma^2}} \right] \right]$$

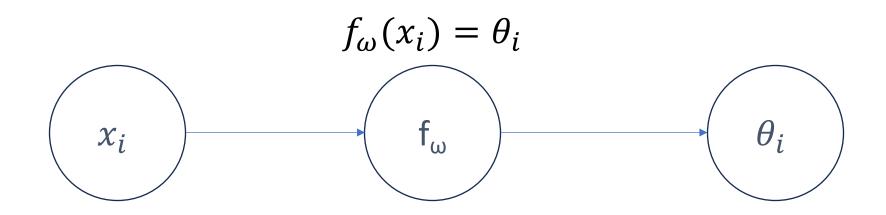
$$\widehat{\omega} = \underset{\omega}{\operatorname{argmin}} \left[\sum_{i=1}^{N} (y_i - f_{\omega}(x_i))^2 \right]$$

$$\text{least squares}$$



Example: binary classification

$$\Pr(y|\lambda) = \begin{cases} 1 - \lambda & y = 0 \\ \lambda & y = 1 \end{cases}$$

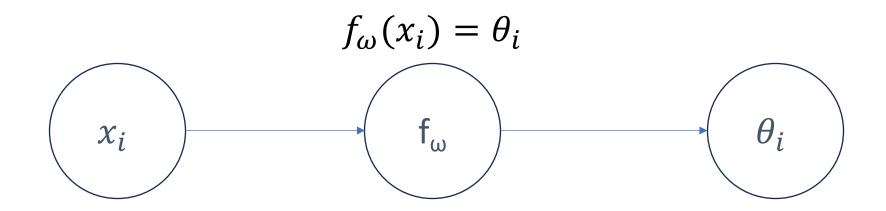


Example: binary classification

$$\Pr(y|\lambda) = \begin{cases} 1 - \lambda & y = 0 \\ \lambda & y = 1 \end{cases}$$

NLL
$$\ell = \sum_{i=1}^{N} -(1 - y_i) \log[1 - \sigma(f_{\omega}(x_i))] - y_i \log[\sigma(f_{\omega}(x_i))]$$

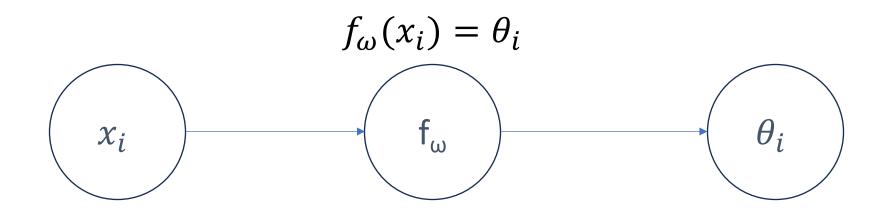
σ: sigmoid function



Example: multiclass classification

$$\Pr(y = k) = \lambda_k$$
 $\sum \lambda_k = 1$ $0 < \lambda_k < 1$

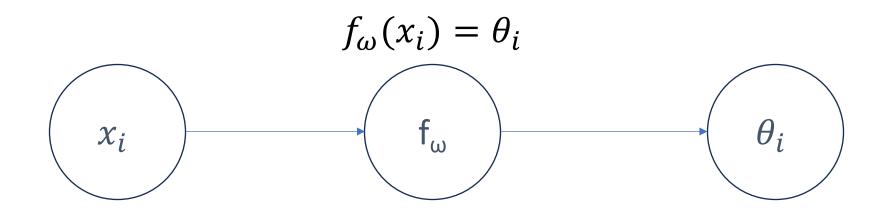
$$\Pr((y = k | x)) = softmax_k[f_{\omega}(x)] \qquad softmax(\mathbf{z}) = \frac{e^{z_k}}{\sum_{k'} e^{z_{k'}}}$$



Example: multiclass classification

$$\Pr(y=k)=\lambda_k \qquad \sum \lambda_k=1$$

NLL
$$\ell = -\sum_{i=1}^{N} \log \left[softmax_{y_i} [f_{\omega}(x_i)] \right]$$



Example: multiclass classification

$$\Pr(y=k)=\lambda_k \qquad \sum \lambda_k=1$$

 $R = -\sum_{i=1}^{N} \log \left[softmax_{y_i} [f_{\omega}(x_i)] \right]$

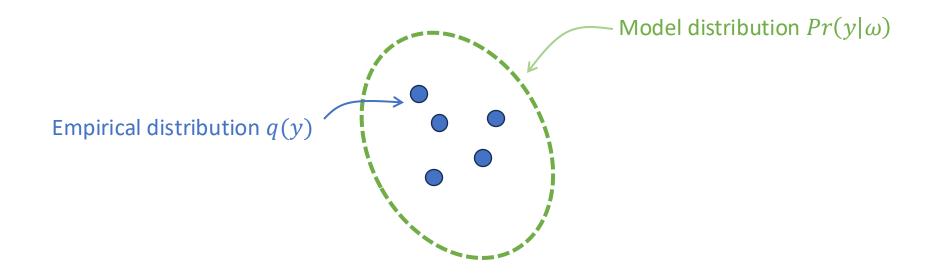
Wait, can we differentiate softmax?

Yes, we can!

NLL

$$\widehat{\omega} = \underset{\omega}{\operatorname{argmin}} \left[-\sum_{i=1}^{N} \log[\Pr(y_i|f_{\omega}(x_i))] \right]$$
 Negative log likelihood (NLL)

is equivalent to the cross-entropy loss



Goal: Minimize divergence between q and p

Given two distributions q(z) and p(z), the distance between the two distributions can be computed with:

$$D_{KL}(q|p) = \int_{-\infty}^{\infty} q(z) \log(q(z)) dz - \int_{-\infty}^{\infty} q(z) \log(p(z)) dz$$

Given an empirical distribution q(y) and a model distribution $Pr(y|\omega)$, we want to minimize the KL divergence:

$$\widehat{\omega} = \underset{\omega}{\operatorname{argmin}} \left[\int_{-\infty}^{\infty} q(y) \log(q(y)) dy - \iint_{-\infty}^{\infty} q(y) \log[\Pr(y|\omega)] dy \right]$$

$$\widehat{\omega} = \underset{\omega}{\operatorname{argmin}} \left[- \iint_{-\infty}^{\infty} q(y) \log[\Pr(y|\omega)] dy \right]$$

Loss functions

Given two distributions q(z) and p(z), the distance between the two distributions can be computed with:

$$D_{KL}(q|p) = \int_{-\infty}^{\infty} q(z) \log(q(z)) dz - \int_{-\infty}^{\infty} q(z) \log(p(z)) dz$$

Given an empirical distribution q(y) and a model distribution $Pr(y|\omega)$, we want to minimize the KL divergence:

entropy of
$$q$$

$$\widehat{\omega} = \underset{\omega}{\operatorname{argmin}} \left[\int_{-\infty}^{\infty} q(y) \log(q(y)) \, dy - \int_{-\infty}^{\infty} q(y) \log[\Pr(y|\omega)] \, dy \right]$$

$$\widehat{\omega} = \underset{\omega}{\operatorname{argmin}} \left[- \int_{-\infty}^{\infty} q(y) \log[\Pr(y|\omega)] \, dy \right]$$

Loss functions

Definition of cross-entropy loss of distribution q relative to distribution p over the set \mathcal{X} :

$$H(q, p) = -E_q[\log p]$$

where $E_q[\cdot]$ is the expected value operator with respect to distribution q.

In the continuous case:

$$H(q,p) = -\int_{\mathcal{X}} Q(x) \log P(x) dx$$

In the discrete case:

$$H(q,p) = -\sum_{x \in \mathcal{X}} q(x) \log p(x)$$

Loss functions

Given an empirical distribution q(y) and a model distribution $Pr(y|\omega)$, we want to minimize the KL divergence:

$$\widehat{\omega} = \underset{\omega}{\operatorname{argmin}} \left[- \iint_{-\infty}^{\infty} q(y) \log[\Pr(y|\omega)] dy \right] \qquad \text{cross-entry loss}$$

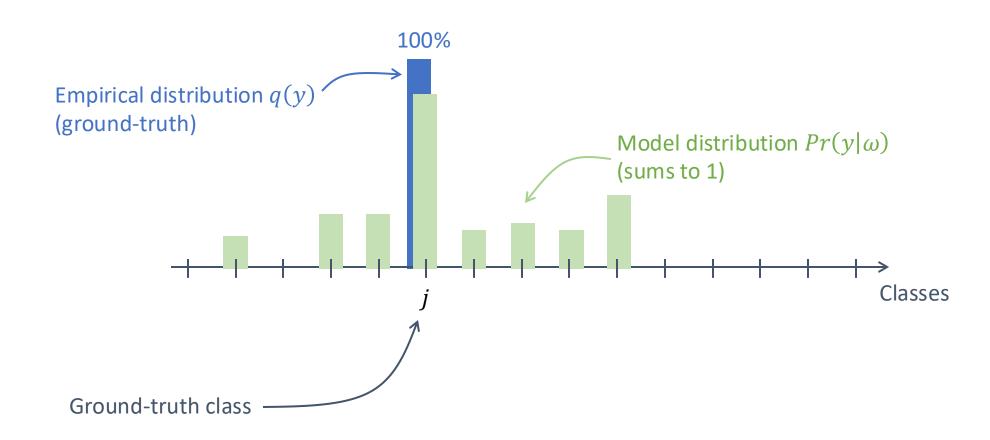
$$\widehat{\omega} = \underset{\omega}{\operatorname{argmin}} \left[- \iint_{-\infty}^{\infty} \left(\frac{1}{N} \sum_{i=1}^{N} \delta[y - y_i] \right) \log[\Pr(y|\omega)] dy \right]$$

$$\widehat{\omega} = \underset{\omega}{\operatorname{argmin}} \left[- \frac{1}{N} \sum_{i=1}^{N} \log[\Pr(y_i|\omega)] \right]$$

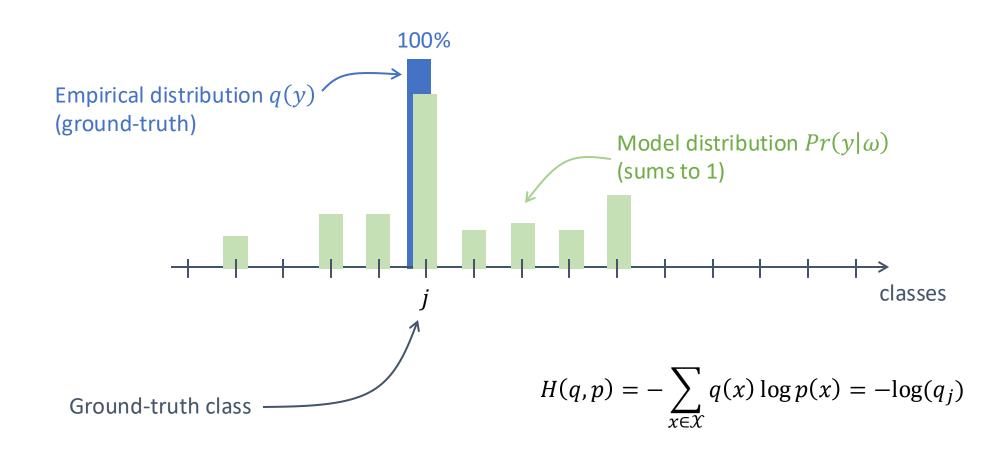
$$\widehat{\omega} = \underset{\omega}{\operatorname{argmin}} \left[- \sum_{i=1}^{N} \log[\Pr(y_i|\omega)] \right]$$

$$NLL$$

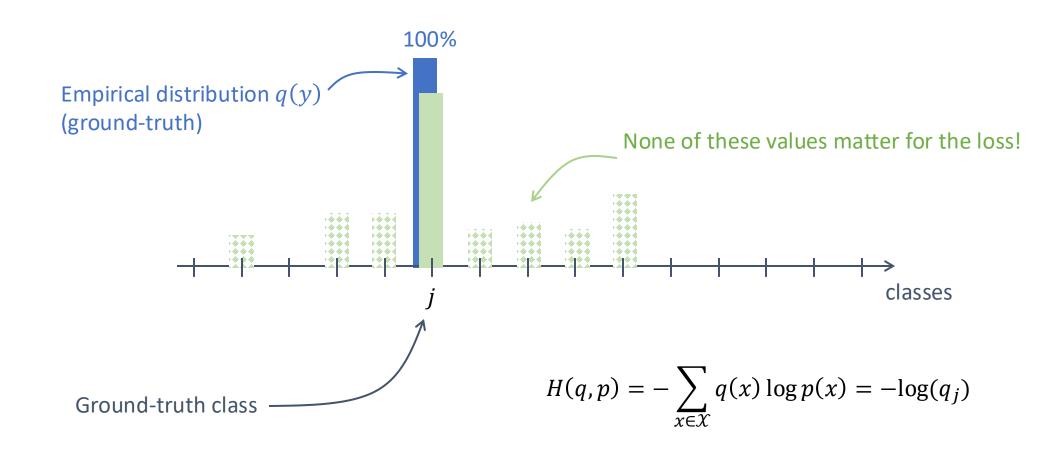
Loss functions: example for classification



Loss functions: example for classification



Loss functions: example for classification

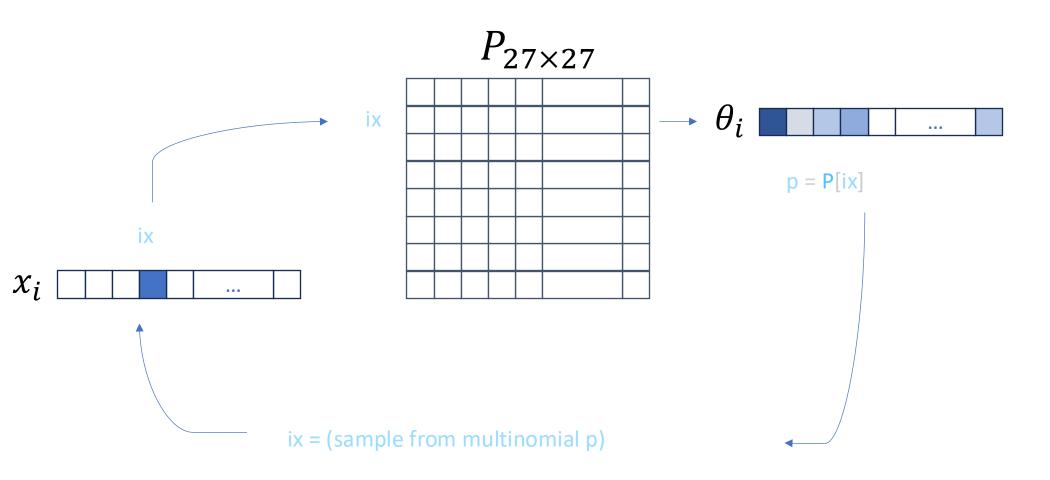


TP2: makemore

Goal: Given a bunch of names, generate more "name-like" words.

- 1. Build a simple bigram model for next-character prediction
- 2. Build the same bigram model using the NLL loss
- 3. Implement a better model: [Bengio et al., 2003]

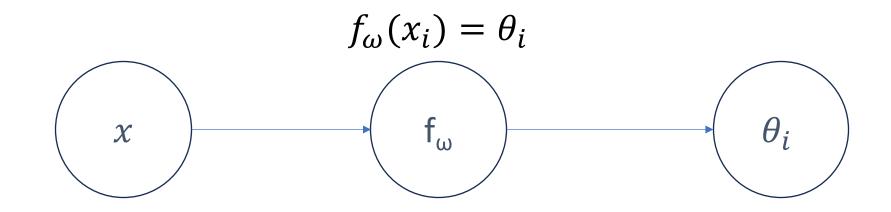
Step 1: bigram "by hand"



The dot character (.) marks the beginning and end of a word.

When sampling, you need to stop when you hit that special character.

How to initialize a torch matrix of size 27x27 containing floats?



$$x_i = [0,0,0,1,0,...0]$$

One-hot encoding of letter 'd'

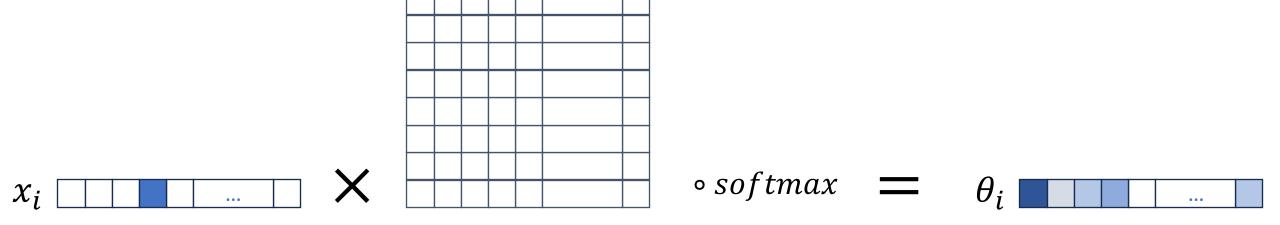
 ω is a matrix $W_{27\times27}$ such that $\theta_i = softmax(x\cdot W)$ is a $N\times27$ vector representing the distribution of the next character for each sample

Step 2: bigram as a learnable matrix



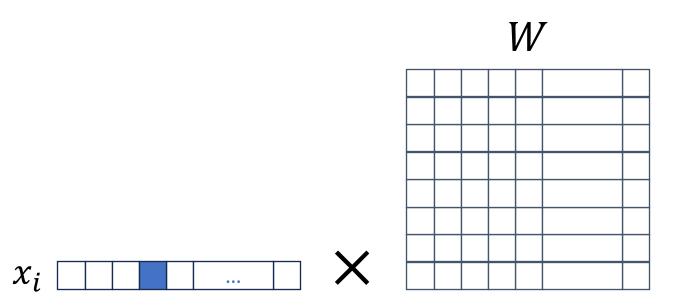
One-hot encoding of letter 'd'

Step 2: bigram as a learnable matrix



W

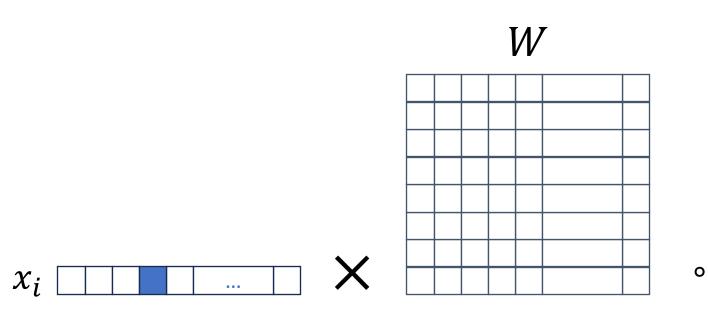
One-hot encoding of letter 'd'



 \circ softmax = θ_i

We want to minimize the KL divergence or NLL

$$\widehat{\omega} = \underset{\omega}{\operatorname{argmin}} \left[-\sum_{i=1}^{N} \log[Pr(y_i|\omega)] \right]$$
 NLL



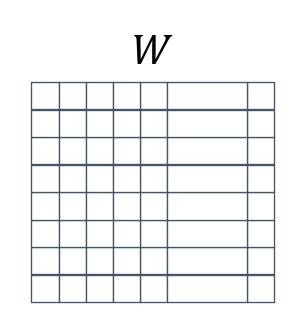
 \circ softmax $= \theta_i$

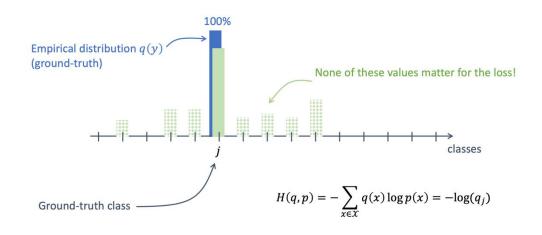
 σ_i ...

We want to minimize the KL divergence or NLL

$$y_i$$
 ...

$$\widehat{\omega} = \underset{\omega}{\operatorname{argmin}} \left[-\sum_{i=1}^{N} \log \underbrace{Pr(y_i|\omega)} \right] \quad NLL$$





 x_i ...

X

 \circ softmax

 $heta_i$ |



We want to minimize the KL divergence or NLL

$$y_i$$
 ...

$$\widehat{\omega} = \underset{\omega}{\operatorname{argmin}} \left[-\sum_{i=1}^{N} \log Pr(y_i|\omega) \right] \quad NLL$$

Step 2: bigram as a learnable matrix



```
#forward pass
xenc = ??? # encode xs with F.one_hot
logits = ??? # multiply by W
counts = ??? # exp(logits)
probs = ??? # softmax
loss = ??? # sum of logs of probs
```

A few tips...

```
import torch.nn.functional as F
```

 $x \cdot W$ is written as $\times @ W$

One-hot encoding: F.one_hot(x, num_classes=...).float()

For inference z.multinomial()

Normalizing a matrix $W_{27\times27}$ by row requires the keepdim parameter somewhere...

A few tips...

```
>>> a = torch.randn((7,7))
>>> a
tensor([[ 1.2555, 0.6821, 0.9131, -0.7238, 0.5636, -2.8689, -0.4744],
    [2.1393, -0.8737, 2.4039, 0.0056, 0.6169, -0.2245, -0.2242],
    [0.1821, -0.4250, -0.1115, -0.3568, -2.2182, 0.9574, 1.9415],
    [-0.2646, 1.7013, -2.7297, 0.3786, -1.7883, 0.8484, -0.1894],
    [-0.5430, -0.2352, 0.4820, -0.0737, 0.8632, 0.1648, 1.1864],
    [1.3596, -0.6411, 2.9097, 0.9422, -0.0167, -0.1453, -0.6059],
    [-0.4946, 0.2705, 0.5348, -1.8176, -1.3861, -1.0276, -1.0050]])
>>> a.sum(axis=1)
tensor([-0.6527, 3.8434, -0.0306, -2.0437, 1.8446, 3.8025, -4.9256])
>>> a.sum(axis=1, keepdim=True)
tensor([[-0.6527],
    [3.8434],
    [-0.0306],
    [-2.0437],
    [1.8446],
    [ 3.8025],
    [-4.9256]]
```

Step 3: A Neural Probabilistic Language Model

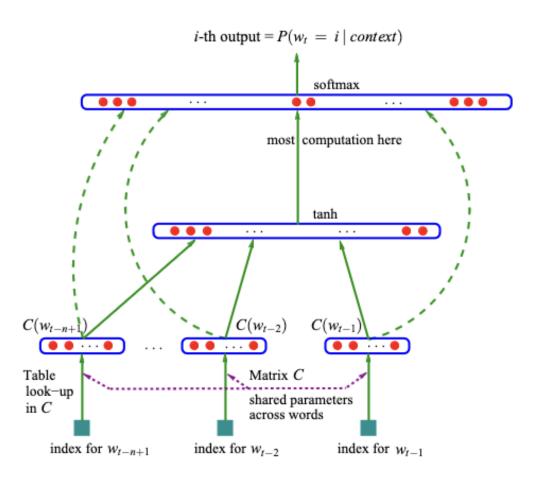


Figure 1: Neural architecture: $f(i, w_{t-1}, \dots, w_{t-n+1}) = g(i, C(w_{t-1}), \dots, C(w_{t-n+1}))$ where g is the neural network and C(i) is the i-th word feature vector.

Step 3: A Neural Probabilistic Language Model

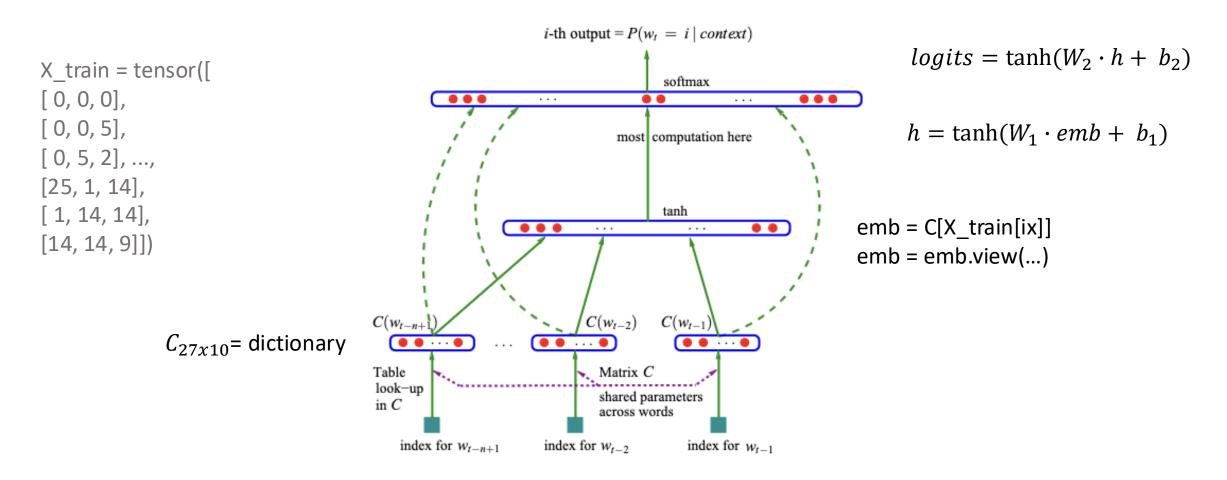


Figure 1: Neural architecture: $f(i, w_{t-1}, \dots, w_{t-n+1}) = g(i, C(w_{t-1}), \dots, C(w_{t-n+1}))$ where g is the neural network and C(i) is the i-th word feature vector.